

Onset of Motion and Glassy Dynamics of a Moving Vortex Lattice

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Abstract. We study the onset of motion of a vortex lattice in response to a driving current that is turned on suddenly. For sufficiently high currents we find that the average vortex velocity (obtained from the longitudinal voltage drop) grows smoothly with time and obeys a stretched exponential with an exponent $\beta \sim 0.7$. The response is governed by two time scales: a delay time (t_0) before the appearance of a measurable voltage drop, and a rise time (τ) characterizing the evolution of voltage response. Both time scales increase with decreasing saturation voltage V_0 : τ decreases exponentially, while t_0 as a power law. When the saturation velocity is too low the response slows down significantly and shows a step structure indicating plastic response.

velocity is described by a stretched exponential function, which is one of the salient properties of a glass [14, 15]. The smooth evolution becomes significantly slower and even shows steps when driven to a low saturation velocity. A dynamic phase diagram is identified accordingly.

2. EXPERIMENTAL

In order to study the dynamic response of a driven vortex lattice, two questions have to be answered: What is the initial stationary state? How to measure the dynamic process?

There are various ways to prepare a vortex lattice. 1) Zero-field-cooling (ZFC), the sample is cooled through its superconducting transition temperature T_c , and then a magnetic field is ramped up. 2) High-field-cooling (HFC), the sample is cooled in a very strong magnetic field, and then the field is ramped down. 3) Field-cooling (FC), the sample is cooled in the fixed field with the given level precisely. 4) Shaking, a small AC field is used to equilibrate the vortex lattice after ZFC or FC. 5) Driving, a driving current is used to help the equilibration. The FC state deserves special attention because as vortices form upon cooling through T_c their density is uniform and remains this way since the procedure does not involve introducing or removing vortices through the sample edges as is the case in the other methods.

Our experimental protocol is as follows. Starting from a freshly prepared FC state, we apply a current pulse and employ a time resolved measurement to monitor the evolution of the voltage induced by the vortex motion. This procedure allows monitoring the vortex lattice motion while it explores its configuration space under controlled experimental conditions.

Experiments were carried out on an un-doped single crystal of $2H-NbSe_2$, with dimensions $4.41 \text{ mm} \times 0.83 \text{ mm} \times 6 \text{ }\mu\text{m}$, transition temperature and width of $T_c = 7.2 \text{ K}$ and 130 mK . The magnetic field was applied along the c-axis and the transport currents were in the a-b plane. Details of the experimental setup have been reported elsewhere [16].

3. RESULTS AND DISCUSSION

$2H-NbSe_2$ is a typical weak pinning type-II superconductor. The static phase diagram of the sample was reported elsewhere [16]. SANS measurements on similar samples exhibit sharp Bragg peaks at low temperatures that are consistent with the formation of a Bragg glass [9,10]. In the following we focus on the dynamics of vortex lattices prepared by an FC process in 0.2 T.

3.1 Dynamic phase diagram

The results on the evolution of the voltage response to an applied current are summarized in fig. 1. For a given temperature the saturation voltage V_0 increases linearly with current, I , as expected from free flux flow (fig. 1a). However, the time scale of the evolution slows down with decreasing V_0 (fig. 1b). As V_0 continues to decrease there is a transition in the behavior of $V(t)$ from fast and smooth to slow and stepwise. In order to capture the main features of $V(t)$ we define a response time, τ_{80} , as the time when 80% of V_0 is reached. Fig.1c is a contour plot of τ_{80} in the V_0 - T plane. Due to the presence of a surface barrier [17], the applied current is not proportional to the bulk current density J . But since J , rather than the total current, determines the driving force on individual vortices, $f_d \sim J$, the applied current is not a reliable measure of the force. Instead we use V_0 as a measure of the driving force:

$$V_0 \propto (f_d - f_p)/\eta \quad (1)$$

where $f_p \sim J_p$ is the pinning force, η the viscosity and J_p is the critical current density. Thus one can treat the vertical axis of fig. 1c as a force axis.

One of the outstanding features of fig. 1c is the existence of a bubble (defined by the squares) within which τ_{80} is several orders of magnitude longer. In the bubble regime the response breaks up into long time steps during which only a fraction of the vortices are moving – a clear signature of plastic response. The arrow in the figure points to the same V_0 as that in fig. 1b showing the definition of the bubble boundary as the locus for the appearance of stepwise response. Another feature is that τ_{80} depends weakly on temperature below ~ 5.70 K (dashed line in fig. 1c) but decreases sharply above it.

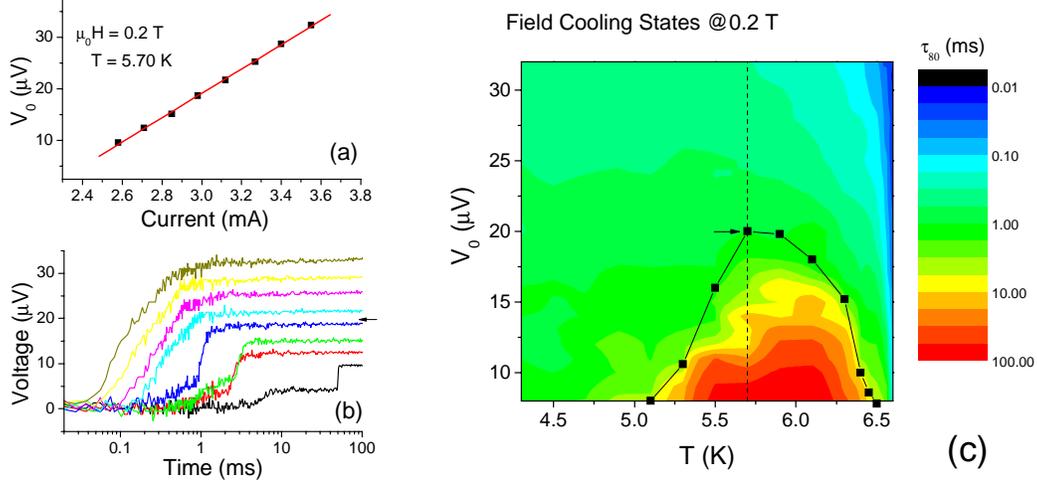


Figure 1. a) Saturation voltage V_0 versus applied current level. The solid line is a fit to free flux flow. b) Time dependence of voltage for different V_0 . The response is smooth at high levels but step-like at low levels. The arrow shows the boundary separating the regimes of elastic and plastic flow. c) The contour plot of response times (see text).

3.2 Evolution toward high velocity

In fig. 2 we show the time dependence of the response in the high velocity regime where it is smooth (outside the bubble of fig. 1c). In this regime the data is well described by a stretched exponential:

$$V(t) = V_0 \left(1 - e^{-\left(\frac{t-t_0}{\tau}\right)^\beta} \right), \quad 0 < \beta < 1 \quad (2)$$

where V_0 is the saturation voltage, t_0 is a waiting time before any voltage appears, τ is the rise time and $\beta = 0.7$. In the same figure we also show that a fit to a simple exponential decay cannot follow the data over the entire range. Similarly a simple logarithmic fit, while adequate for short times must deviate from the data at longer times. The stretched exponential response observed here is one of the hallmarks of glassy behavior [14, 15]. It arises in the presence of many competing response times with the exponent typically characterizing the distribution of these times. The stretched exponential response inevitably arises when the dynamics of competing mechanisms is hierarchically constrained [15].

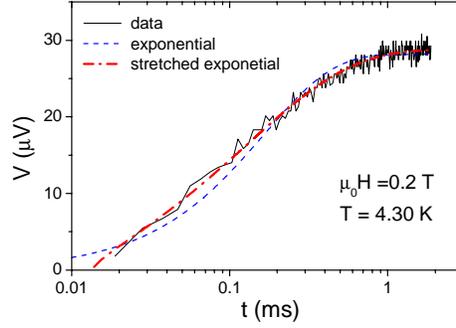


Figure 2. Time evolution of vortex response to an applied current pulse. The fits show that the response is best described by a stretched exponential function (equation 2 in the text) with $\beta=0.7$.

In Fig. 3 we show the temperature dependence of the fitting parameters τ , t_0 , and β obtained by fitting the data for $V(t)$ to the stretched exponential function in equation 2 over the experimental temperature range. The upper panels describing the low temperature data are almost identical indicating weak temperature dependence consistent with the contour plot of Fig 1c. The average value of the exponent is found to be $\beta \sim 0.7$, with a scatter that decreases significantly at higher velocities.

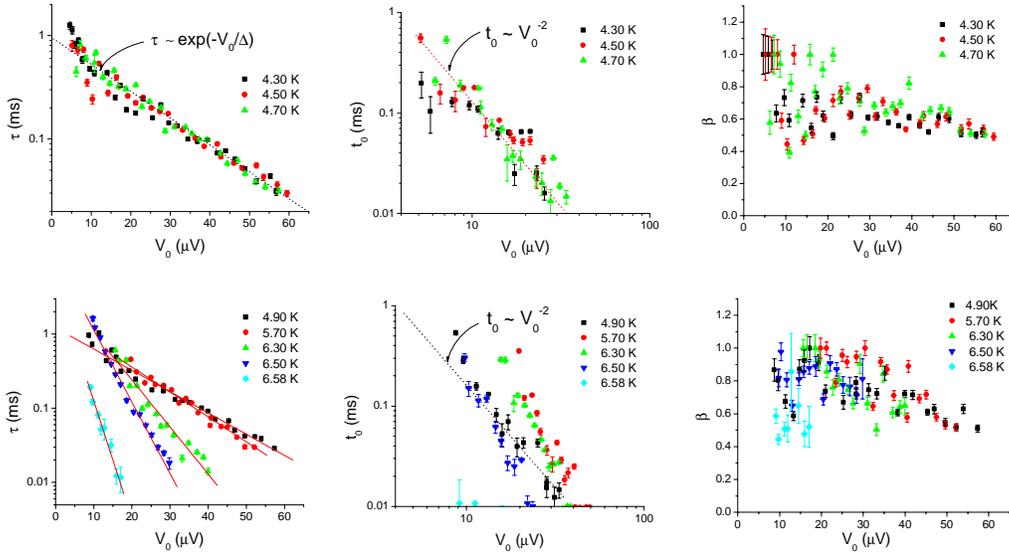


Figure 3. Fitting parameters as a function of saturation voltage obtained by fitting the voltage response with a stretched exponential at low temperatures (upper panels) and high temperatures (lower panels). The solid lines are fits to an exponential and the dotted lines are guides to the eye.

We note that the relaxation time τ decreases exponentially with V_0 while the delay time t_0 is better described by a power law $t_0(V_0) \sim V_0^{-\alpha}$. The power law dependence suggests a divergence in the delay time at the depinning threshold, $V_0 \sim 0$. In the lower panels of Fig. 3 we note the onset of temperature dependence of the fitting parameters for $T > 5.7$ K, however the exponential dependence of $\tau(V_0)$ persists at all temperatures. In fig. 4 we plot the temperature dependence of the exponent α and of t_0 at $V_0 = 10 \mu\text{V}$. We note that the power increases almost linearly with temperature.

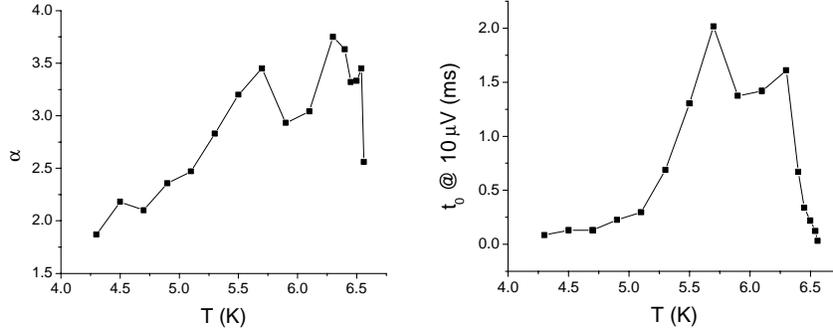


Figure 4. (left) Temperature dependence of the power α in $t_0 \sim V_0^{-\alpha}$. (right) Temperature dependence of t_0 at $10 \mu\text{V}$.

3.3 Discussion

When the vortex lattice moves in response to an applied current pulse it undergoes a transition from static to moving state and since the moving state is more ordered than the stationary one [18,19], the finite response time can be attributed to the time to heal lattice defects. If we assume that healing proceeds by an activated process with barrier $U(V_0, T)$ [16] the time scale of the defect healing rate would be given by $\tau \sim \exp(U/T)$. For a driven lattice the effect of the applied current on the barrier can be estimated using the Anderson Kim model [20] $U(J) \sim U_c(1 - J/J_c)$ where U_c is the static barrier due to pinning. Using equation 1 we find $J = V_0 / \rho_{ff} l + J_c$, where $\rho_{ff} = \rho_n H/H_{c2}$ is the free flux flow resistivity and l the distance between voltage leads. Thus we can write

$$\tau(V_0) = \tau_0 e^{-\gamma/T} \quad (3)$$

with $\gamma = U_c T / \rho_{ff} l J_c$ and $\tau_0 \sim N_0(T)$ where $N_0(T) \sim e^{\alpha T}$ is the number of defects in the initial lattice [16].

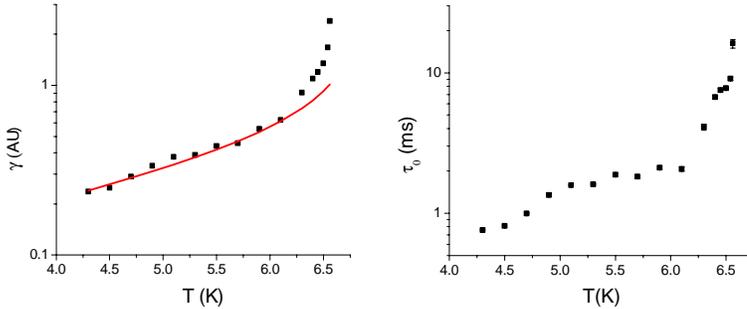


Figure 5. Temperature dependence of γ and τ_0 obtained by fitting to equation (3). The solid line in the left panel describes the temperature dependence of γ calculated by assuming an activation process for healing defects and an Anderson-Kim model to describe the effect of the driving force on the barrier.

The values of $\gamma(T)$ and $\tau_0(T)$ obtained from fitting the data are plotted in figure 5. In the left panel we compare the temperature dependence of the measured $\gamma(T)$ to that obtained from a collective pinning [2] model $U_c T / \rho_{ff} l J_c \sim (T_c - T)^{-1/2}$ (solid curve) where $T_c = 6.9\text{K}$ is the critical temperature of

the sample at 0.2 T. We note that for $T < 6$ K this model captures the temperature dependence $\chi(T)$. At higher temperatures the deviation from this model suggests that a new mechanism, such as injection of defects through sample edges, further slows down the healing process.

4. SUMMARY

We have studied the dynamic evolution of a vortex lattice from stationary to moving state in response to an applied current pulse. We find that the time evolution of the response follows a stretched exponential with exponent $\beta \sim 0.7$, as expected of a glassy system. The response is characterized by two time scales, a delay time t_0 and a characteristic response time τ . Both time scales depend on the saturation voltage, with $t_0(V_0) \sim V_0^{-\alpha}$, $\alpha \sim 1.8-3.8$ and $\tau(V_0) = \tau_0 e^{-\mathcal{N}_0/T}$, $\chi(T) \sim (T-T_c)^{-1/2}$ for sufficiently large values of V_0 and low temperatures. When the vortex lattice is driven towards a low V_0 , plastic processes set in leading to the appearance of steps and non-monotonous response. We attribute the time evolution of the response to a process of defect healing in the vortex lattice and show that the temperature dependence of the response is consistent with an activation process over a barrier that is reduced in the presence of the applied current according to the Anderson Kim model.

Acknowledgments

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